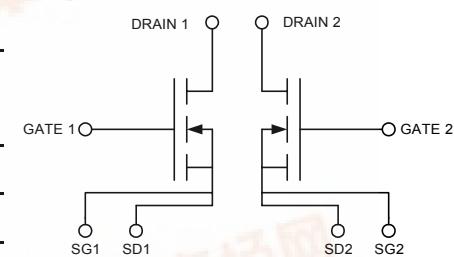
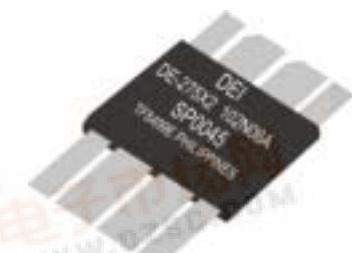




DE275X2-102N06A

RF Power MOSFET

Preliminary Data Sheet

 V_{DSS} = 1000 V I_{D25} = 6 A $R_{DS(on)}$ = 2.0 Ω P_{DHS} = 750 W

- ◆ Common Source Push-Pull Pair
- ◆ N-Channel Enhancement Mode
- ◆ Low Q_g and $R_{DS(on)}$
- ◆ High dv/dt
- ◆ Nanosecond Switching

The DE275X2-102N06A is a matched pair of RF power MOSFET devices in a common source configuration. The device is optimized for push-pull or parallel operation in RF generators and amplifiers at frequencies to >65 MHz.

Unless noted, specifications are for each output device

Symbol	Test Conditions	Maximum Ratings		
V_{DSS}	$T_J = 25^\circ\text{C}$ to 150°C	1000	V	
V_{DGR}	$T_J = 25^\circ\text{C}$ to 150°C ; $R_{GS} = 1 \text{ M}\Omega$	1000	V	
V_{GS}	Continuous	± 20	V	
V_{GSM}	Transient	± 30	V	
I_{D25}	$T_c = 25^\circ\text{C}$	6	A	
I_{DM}	$T_c = 25^\circ\text{C}$, pulse width limited by T_{JM}	48	A	
I_{AR}	$T_c = 25^\circ\text{C}$	6	A	
E_{AR}	$T_c = 25^\circ\text{C}$	20	mJ	
dv/dt	$I_S \leq I_{DM}$, $di/dt \leq 100\text{A}/\mu\text{s}$, $V_{DD} \leq V_{DSS}$, $T_J \leq 150^\circ\text{C}$, $R_G = 0.2\Omega$	5	V/ns	
	$I_S = 0$	>200	V/ns	
$P_{DHS}^{(1)}$	$T_c = 25^\circ\text{C}$, Derate 6.0W/ $^\circ\text{C}$ above 25°C	750	W	
$P_{DAMB}^{(1)}$	$T_c = 25^\circ\text{C}$	5.0	W	
$R_{thJHS}^{(1)}$		0.17	K/W	
T_J		-55...+150	°C	
T_{JM}		150	°C	
T_{stg}		-55...+150	°C	
T_L	1.6mm (0.063 in) from case for 10 s	300	°C	
Weight		4	g	

Symbol	Test Conditions	Characteristic Values		
		min.	typ.	max.
V_{DSS}	$V_{GS} = 0 \text{ V}$, $I_D = 3 \text{ mA}$	1000		V
$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 4 \text{ mA}$	2.5		5.5 V
I_{GSS}	$V_{GS} = \pm 20 \text{ V}_{DC}$, $V_{DS} = 0$			$\pm 100 \text{ nA}$
I_{DSS}	$V_{DS} = 0.8 V_{DSS}$ $T_J = 25^\circ\text{C}$ $V_{GS} = 0$ $T_J = 125^\circ\text{C}$			50 μA 1 mA
g_{fs}	$V_{GS} = 15 \text{ V}$, $I_D = 0.5I_{D25}$, Pulse test, $t \leq 300\mu\text{s}$, duty cycle d $\leq 2\%$			2.5 Ω
	$V_{DS} = 15 \text{ V}$, $I_D = 0.5I_{D25}$, pulse test	2	6	S

Features

- Isolated Substrate
 - high isolation voltage ($>2500\text{V}$)
 - excellent thermal transfer
 - Increased temperature and power cycling capability
- IXYS advanced low Q_g process
- Low gate charge and capacitances
 - easier to drive
 - faster switching
- Low $R_{DS(on)}$
- Very low insertion inductance ($<2\text{nH}$)
- No beryllium oxide (BeO) or other hazardous materials

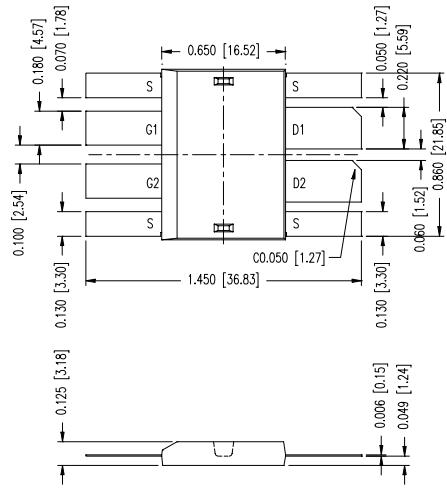
Advantages

- High Performance Push-Pull RF Package
- Optimized for RF and high speed switching at frequencies to $>100\text{MHz}$
- Easy to mount—no insulators needed
- High power density

Note: All specifications are per each transistor, unless otherwise noted.

⁽¹⁾ Thermal specifications are for the package, not per transistor

Symbol	Test Conditions	Characteristic Values (T _J = 25°C unless otherwise specified)		
		min.	typ.	max.
R _G		0.3		Ω
C _{iss}		1800		pF
C _{oss}	V _{GS} = 0 V, V _{DS} = 0.8 V _{DSS(max)} , f = 1 MHz	100		pF
C _{rss}		30		pF
T _{d(on)}		3		ns
T _{on}	V _{GS} = 15 V, V _{DS} = 0.8 V _{DSS} I _D = 0.5 I _{DM}	2		ns
T _{d(off)}	R _G = 0.2 Ω (External)	4		ns
T _{off}		5		ns
Q _{g(on)}		50		nC
Q _{gs}	V _{GS} = 10 V, V _{DS} = 0.5 V _{DSS} I _D = 0.5 I _{D25}	20		nC
Q _{gd}		30		nC



Symbol	Test Conditions	Characteristic Values (T _J = 25°C unless otherwise specified)		
		min.	typ.	max.

Symbol	Test Conditions	min.	typ.	max.
I _S	V _{GS} = 0 V			6 A
I _{SM}	Repetitive; pulse width limited by T _{JM}			48 A
V _{SD}	I _F = I _S , V _{GS} = 0 V, Pulse test, t ≤ 300 μs, duty cycle ≤ 2%			1.5 V
T _{rr}		200		ns
Q _{RM}	I _F = I _S , -di/dt = 100A/μs, V _R = 100V	0.6		μC
I _{RM}		4		A

(1) These parameters apply to the package, not individual MOSFET devices.

For detailed device mounting and installation instructions, see the "DE-Series MOSFET Mounting Instructions" technical note on DEI's web site at www.directedenergy.com/apptech.htm

Directed Energy, Inc. reserves the right to change limits, test conditions and dimensions.

DEI MOSFETS are covered by one or more of the following U.S. patents:

4,835,592	4,850,072	4,881,106	4,891,686	4,931,844	5,017,508
5,034,796	5,049,961	5,063,307	5,187,117	5,237,481	5,486,715
5,381,025	5,640,045				

102N06A DE-SERIES SPICE Model

The DE-SERIES SPICE Model is illustrated in Figure 1. The model is an expansion of the SPICE level 3 MOSFET model. It includes the stray inductive terms L_G , L_S and L_D . R_d is the $R_{DS(ON)}$ of the device, R_{ds} is the resistive leakage term. The output capacitance, C_{OSS} , and reverse transfer capacitance, C_{RSS} are modeled with reversed biased diodes. This provides a varactor type response necessary for a high power device model. The turn on delay and the turn off delay are adjusted via R_{on} and R_{off} .

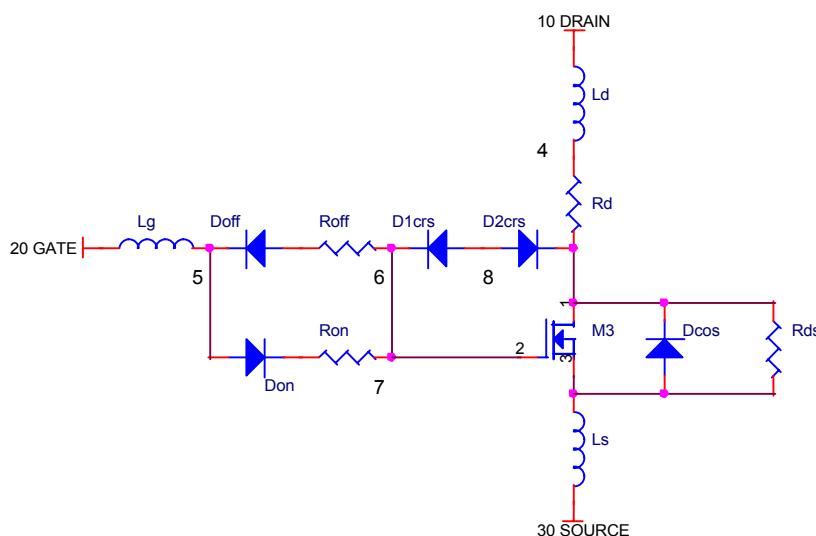


Figure 1 DE-SERIES SPICE Model

This SPICE model may be downloaded as a text file from the DEI web site at www.directedenergy.com/spice.htm

Net List:

```
*SYM=POWMOSN
.SUBCKT 102N06A 10 20 30
* TERMINALS: D G S
* 1000 Volt 6 Amp 2.0 Ohm N-Channel Power MOSFET
M1 1 2 3 3 DMOS L=1U W=1U
RON 5 6 .5
DON 6 2 D1
ROF 5 7 1.0
DOF 2 7 D1
D1CRS 2 8 D2
D2CRS 1 8 D2
CGS 2 3 1.9N
RD 4 1 1.7
DCOS 3 1 D3
RDS 1 3 5.0MEG
LS 3 30 .5N
LD 10 4 1N
LG 20 5 1N
.MODEL DMOS NMOS (LEVEL=3 VTO=4 KP=2.3)
.MODEL D1 D (IS=.5F CJO=10P BV=100 M=.5 VJ=.2 TT=1N)
.MODEL D2 D (IS=.5F CJO=400P BV=1000 M=.6 VJ=.6 TT=1N RS=10M)
.MODEL D3 D (IS=.5F CJO=400P BV=1000 M=.35 VJ=.6 TT=400N RS=10M)
.ENDS
```

Doc #9200-0224 Rev 2
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